

**Search Notes**

Application/Control No.

10/786,388

Examiner

Binh X. Tran

Applicant(s)/Patent under  
Reexamination

STRECK ET AL.

Art Unit

1765

**SEARCHED**

Class	Subclass	Date	Examiner
438	746	3/14/2006	B T
438	747	3/14/2006	B T
438	756	3/14/2006	B T

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search keywords and inventor's names using USPAT, USPG-PUB, JPO, EPO, DERWENT databases	3/14/2006	B T